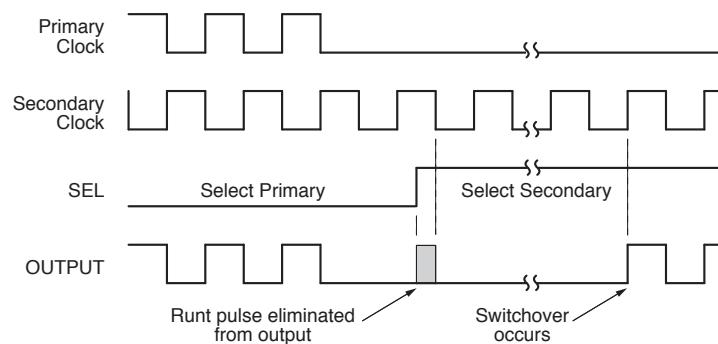
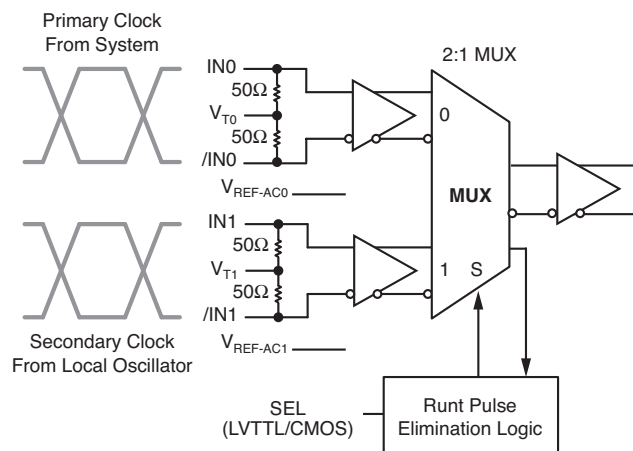


Typical Application



Simplified Example Illustrating Runt Pulse Eliminator (RPE) Circuit when Primary Clock Fails

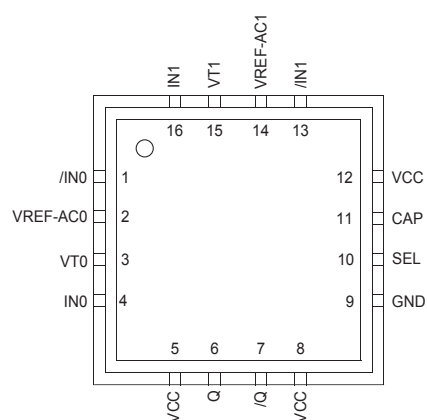
Ordering Information⁽¹⁾

Part Number	Package Type	Operating Range	Package Marking	Lead Finish
SY89841UMG	MLF-16	Industrial	841U with Pb-Free bar-line Indicator	NiPdAu Pb-Free
SY89841UMGTR ⁽²⁾	MLF-16	Industrial	841U with Pb-Free bar-line Indicator	NiPdAu Pb-Free

Notes:

1. Contact factory for die availability. Dice are guaranteed at $T_A = 25^\circ\text{C}$, DC Electricals Only.
2. Tape and Reel.

Pin Configuration



16-Pin MLF™ (MLF-16)

Pin Description

Pin Number	Pin Name	Pin Function
4, 1, 16, 13	IN0, /IN0, IN1, /IN1	Differential Inputs: These input pairs are the differential signal inputs to the device. These inputs accept AC- or DC-coupled signals as small as 100mV. Each pin of a pair internally terminates to a VT pin through 50Ω. Please refer to the “Input Interface Applications” section for more details.
2, 14	VREF-AC0 VREF-AC1	Reference Voltage: This output biases to $V_{CC} - 1.2V$. It is used for AC-coupling inputs IN and /IN. Connect V_{REF-AC} directly to the corresponding VT pin. Bypass with 0.01μF low ESR capacitor to V_{CC} . Maximum sink/source current is ±1.5mA. Due to the limited drive capability, the VREF-AC pin is only intended to drive its respective VT pin. See the “Input Interface Applications” section for more details.
3, 15	VT0, VT1	Input Termination Center-Tap: Each side of the differential input pair terminates to a VT pin. The VT0 and VT1 pins provide a center-tap to a termination network for maximum interface flexibility. See the “Input Interface Applications” section for more details.
5, 8, 12	VCC	Positive Power Supply: Bypass with 0.1μF//0.01μF low ESR capacitors as close to the VCC pins as possible.
6, 7	Q, /Q	Differential Outputs: This LVDS differential output is a logic function of the IN0, IN1, and SEL inputs. Please refer to the truth table below for details.
10	SEL	This single-ended TTL/CMOS-compatible input selects the inputs to the multiplexer. Note that this input is internally connected to a 25kΩ pull-up resistor and will default to logic HIGH state if left open.
9	GND Exposed Pad	Ground: Ground and exposed pad must be connected to the same ground plane.
11	CAP	Power-On Reset (POR) Initialization capacitor. When using the multiplexer with RPE capability, this pin is tied to a capacitor to V_{CC} . The purpose is to ensure the internal RPE logic starts up in a known state. See “Power-On Reset (POR) Description” section for more details regarding capacitor selection. If this pin is tied directly to V_{CC} , the RPE function will be disabled and the multiplexer will function as a normal multiplexer. The CAP pin should never be left open.

Truth Table

Inputs					Outputs	
IN0	/IN0	IN1	/IN1	SEL	Q	/Q
0	1	X	X	0	0	1
1	0	X	X	0	1	0
X	X	0	1	1	0	1
X	X	1	0	1	1	0

Absolute Maximum Ratings⁽¹⁾

Supply Voltage (V_{CC})..... -0.5V to +4.0V
 Input Voltage (V_{IN})..... -0.5V to V_{CC}
 Termination Current
 Source or sink current on V_T ± 100 mA
 Source or sink current on IN , $/IN$ ± 50 mA
 V_{REF-AC} Source or sink current..... ± 2 mA
 Lead Temperature (soldering, 20 sec.)..... +260°C
 Storage Temperature (T_s) -65°C to 150°C

Operating Ratings⁽²⁾

Supply Voltage (V_{CC}) +2.375V to +2.625V
 Ambient Temperature (T_A) -40°C to +85°C
 Package Thermal Resistance⁽³⁾
 MLF™ (θ_{JA})
 Still-Air 60°C/W
 MLF™ (ψ_{JB})
 Junction-to-Board 33°C/W

DC Electrical Characteristics⁽⁴⁾

$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$, unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
V_{CC}	Power Supply		2.375		2.625	V
I_{CC}	Power Supply Current	No load, max V_{CC}		85	120	mA
R_{IN}	Input Resistance (IN -to- V_T)		45	50	55	Ω
R_{DIFF_IN}	Differential Input Resistance (IN -to- $/IN$)		90	100	110	Ω
V_{IH}	Input High Voltage (IN , $/IN$)		1.2		V_{CC}	V
V_{IL}	Input Low Voltage (IN , $/IN$)		0		$V_{IH}-0.1$	V
V_{IN}	Input Voltage Swing (IN , $/IN$)	See Figure 1a. Note 5.	0.1		V_{CC}	V
V_{DIFF_IN}	Differential Input Voltage Swing IIN -/ INI	See Figure 1b.	0.2			V
V_{IN_FSI}	Input Voltage Threshold that Triggers FSI			30	100	mV
V_{T_IN}	IN -to- V_T (IN , $/IN$)				1.28	V
V_{REF-AC}	Output Reference Voltage		$V_{CC}-1.3$	$V_{CC}-1.2$	$V_{CC}-1.1$	V

Notes:

1. Permanent device damage may occur if absolute maximum ratings are exceeded. This is a stress rating only and functional operation is not implied at conditions other than those detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
2. The data sheet limits are not guaranteed if the device is operated beyond the operating ratings.
3. Package Thermal Resistance assumes exposed pad is soldered (or equivalent) to the devices most negative potential on the PCB. θ_{JA} and ψ_{JB} values are determined for a 4-layer board in still air unless otherwise stated.
4. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.
5. $V_{IN(max)}$ is specified when V_T is floating.

LVDS Outputs DC Electrical Characteristics⁽⁷⁾

$V_{CC} = 2.5V \pm 5\%$; $R_L = 100\Omega$ across output pair or equivalent; $T_A = -40^\circ C$ to $+85^\circ C$, unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
V_{OCM}	Output Common Mode Voltage		1.125		1.275	V
ΔV_{OCM}	Change in Common Mode Voltage		-50		+50	mV
V_{OUT}	Output Voltage Swing	See Figure 1a.	250	350		mV
$V_{DIFF-OUT}$	Differential Output Voltage Swing	See Figure 1b.	500	700		mV

LVTTL/CMOS DC Electrical Characteristics⁽⁷⁾

$V_{CC} = 2.5V \pm 5\%$; $T_A = -40^\circ C$ to $+85^\circ C$, unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
V_{IH}	Input HIGH Voltage		2.0			V
V_{IL}	Input LOW Voltage				0.8	V
I_{IH}	Input HIGH Current		-125		30	μA
I_{IL}	Input LOW Current		-300			μA

Note:

7. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.

AC Electrical Characteristics⁽⁸⁾

$V_{CC} = 2.5V \pm 5\%$; $R_L = 100\Omega$ across output pair or equivalent; $T_A = -40^\circ C$ to $+85^\circ C$, unless otherwise stated.

Symbol	Parameter	Condition	Min	Typ	Max	Units
f_{MAX}	Maximum Operating Frequency	Clock	1.5	2.0		GHz
t_{pd}	Differential Propagation Delay					
	In-to-Q	$V_{IN} = 100mV$ to $200mV^{(9)}$	470	625	870	ps
	In-to-Q	$V_{IN} = 200mV$ to $800mV^{(9)}$	440	575	800	ps
	SEL-to-Q	RPE enabled, see Timing Diagram			17	cycles
	SEL-to-Q	RPE disabled ($V_{IN} = V_{CC}/2$)	550		900	ps
t_{pd} Tempco	Differential Propagation Delay Temperature Coefficient			115		fs/ $^\circ C$
t_{SKEW}	Part-to-Part Skew	Note 10			200	ps
t_{Jitter}	Random Jitter	Note 11			1	ps _(rms)
	Cycle-to-Cycle Jitter	Note 12			1	ps _(rms)
	Total Jitter (TJ)	Note 13			10	ps _(pp)
	Crosstalk-Induced Jitter	Note 14			0.7	ps _(rms)
t_r, t_f	Output Rise/Fall Time (20% to 80%)	At full output swing.	30	70	150	ps

Notes:

8. High-frequency AC-parameters are guaranteed by design and characterization.
9. Propagation delay is measured with input $t_r, t_f \leq 300ps$ (20% to 80%) and $V_{IL} \geq 800mV$.
10. Part-to-part skew is defined for two parts with identical power supply voltages at the same temperature and with no skew of the edges at the respective inputs.
11. Random Jitter is measured with a K28.7 character pattern, measured at $<f_{MAX}$.
12. Cycle-to-cycle jitter definition: the variation of periods between adjacent cycles, $T_n - T_{n-1}$ where T is the time between rising edges of the output signal.
13. Total Jitter definition: with an ideal clock input of frequency $<f_{MAX}$, no more than one output edge in 10^{12} output edges will deviate by more than the specified peak-to-peak jitter value.
14. Crosstalk is measured at the output while applying two similar differential clock frequencies that are asynchronous with respect to each other at the inputs.

Functional Description

RPE MUX and Fail-Safe Input

The SY89841U is optimized for clock switchover applications where switching from one clock to another clock without runt pulses (short cycles) is required. It features two unique circuits:

Runt-Pulse Eliminator (RPE) Circuit

The RPE MUX provides a “glitchless” switchover between two clocks and prevents any runt pulses from occurring during the switchover transition. The design of both clock inputs is identical (i.e., the switchover sequence and protection is symmetrical for both input pair, IN0 or IN1. Thus, either input pair may be defined as the primary input). If not required, the RPE function can be permanently disabled to allow the switchover between inputs to occur immediately. If the CAP pin is tied directly to VCC, the RPE function will be disabled and the multiplexer will function as a normal multiplexer.

Fail-Safe Input (FSI) Circuit

The FSI function provides protection against a selected input pair that drops below the minimum amplitude requirement. If the selected input pair drops sufficiently below the 100mV minimum single-ended input amplitude limit (V_{IN}), or 200mV differentially (V_{diff_IN}), the output will latch to the last valid clock state.

RPE and FSI Functionality

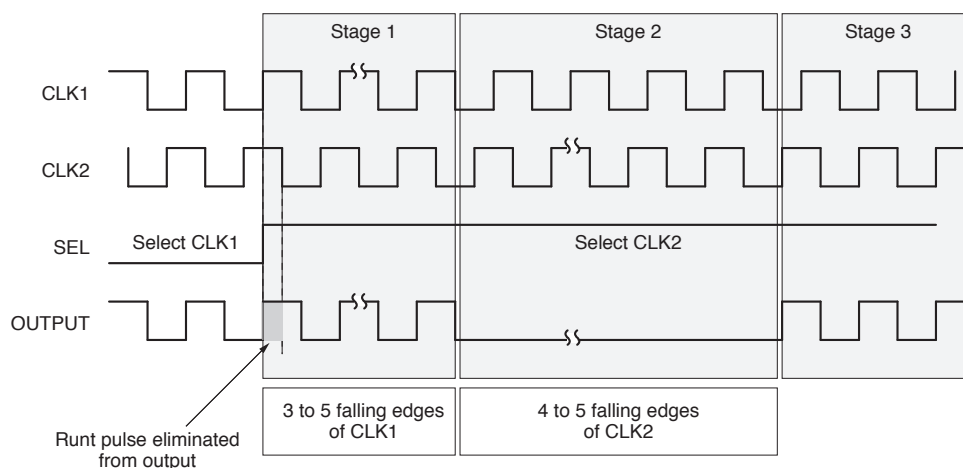
The basic operation of the RPE MUX and FSI functionality is described with the following four case descriptions. All descriptions are related to the true inputs and outputs. The primary (or selected) clock is called CLK1; the secondary (or alternate) clock is called CLK2. Due to the totally asynchronous relation of the IN and SEL signals and an additional internal protection against metastability, the number of pulses required for the operations described in cases 1-4 can vary within certain limits. Refer to “Timing Diagrams” section for detailed information.

Case #1: Two Normal Clocks and RPE Enabled

In this case, the frequency difference between the two running clocks, IN0 and IN1, must not be greater than 1.5:1. For example, if the IN0 clock is 500MHz, the IN1 clock must be within the range of 334MHz to 750MHz.

If the SEL input changes state to select the alternate clock, the switchover from CLK1 to CLK2 will occur in three stages.

- Stage 1: The output will continue to follow CLK1 for a limited number of pulses.
- Stage 2: The output will remain LOW for a limited number of pulses of CLK2.
- Stage 3: The output follows CLK2.

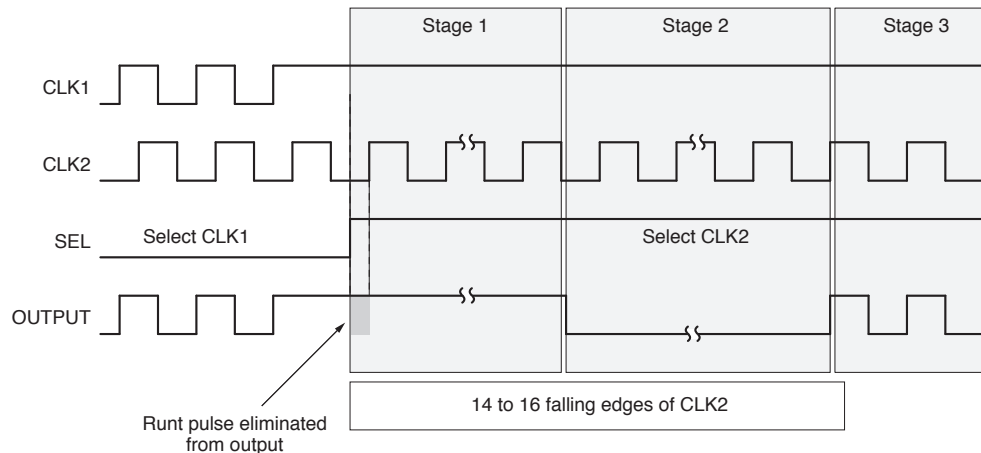


Timing Diagram 1

Case #2: Input Clock Failure: Switching from a selected clock stuck HIGH to a valid clock (RPE enabled).

If CLK1 fails HIGH before the RPE MUX selects CLK2 (using the SEL pin), the switchover will occur in three stages.

- Stage 1: The output will remain HIGH for a limited number of pulses of CLK2.
- Stage 2: The output will switch to LOW and then remain LOW for a limited number of falling edges of CLK2.
- Stage 3: The output will follow CLK2.



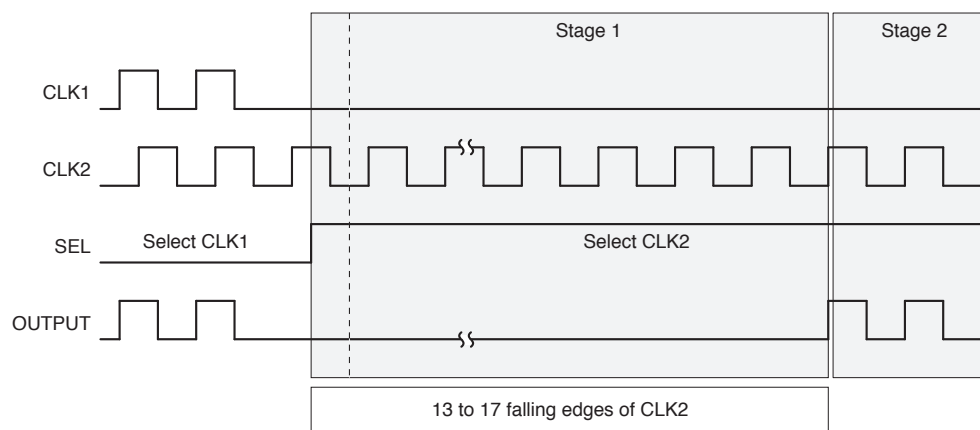
Timing Diagram 2

Note: Output show extended clock cycle during switchover. Pulse width for both high and low of this cycle will always be greater than 50% of the CLK2 period.

Case #3: Input Clock Failure: Switching from a selected clock stuck Low to a valid clock (RPE enabled).

If CLK1 fails LOW before the RPE MUX selects CLK2 (using the SEL pin), the switchover will occur in two stages.

- Stage 1: The output will remain LOW for a limited number of falling edges of CLK2.
- Stage 2: The output will follow CLK2.



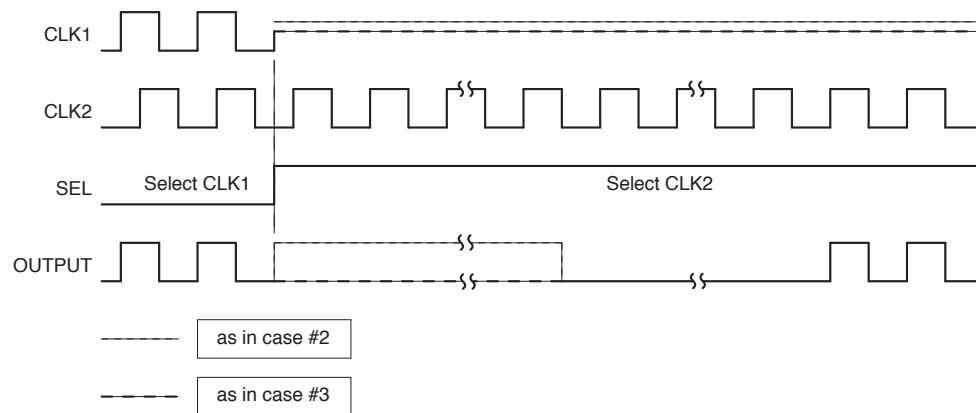
Timing Diagram 3

Case #4: Input Clock Failure: Switching from the selected clock input stuck in an undetermined state to a valid clock input (RPE enabled).

If CLK1 fails to an undetermined state (e.g., amplitude falls below the 100mV (V_{IN}) minimum single-ended input limit, or 200mV differentially) before the RPE MUX selects CLK2 (using the SEL pin), the switchover to the valid clock CLK2 will occur either following Case #2 or Case #3, depending upon the last valid state at the CLK1

If the selected input clock fails to a floating, static, or extremely low signal swing, including 0mV, the FSI function will eliminate any metastable condition and guarantee a stable output signal. No ringing and no undetermined state will occur at the output under these conditions.

Please note that the FSI function will not prevent duty cycle distortions or runt pulses in case of a slowly deteriorating (but still toggling) input signal. Due to the FSI function, the propagation delay will depend on rise and fall time of the input signal and on its amplitude. Refer to "Typical Operating Characteristics" for detailed information.



Timing Diagram 4

Power-On Reset (POR) Description

The SY89841U includes an internal power-on reset (POR) function to ensure the RPE logic starts-up in a known logic state once the power-supply voltage is stable. An external capacitor connected between V_{CC} and the CAP pin (pin 11) controls the delay for the power-on reset function.

The required capacitor value calculation is based upon the time the system power supply needs to power up to a minimum of 2.3V. The time constant for the internal power-on-reset must be greater than the time required for the power supply to ramp up to a minimum of 2.3V.

The following formula describes this relationship:

$$C(\mu F) \geq \frac{t_{dPS}(ms)}{12(ms/\mu F)}$$

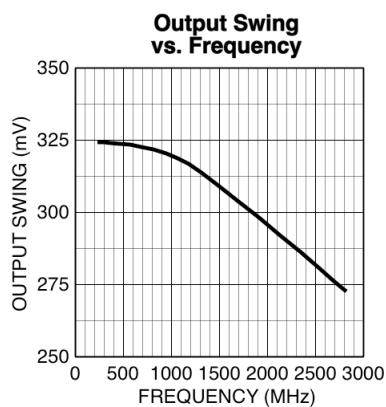
As an example, if the time required for the system power supply to power up past 2.3V is 12ms, then the required capacitor value on pin 11 would be:

$$C(\mu F) \geq \frac{12ms}{12(ms/\mu F)}$$

$$C \geq 1\mu F$$

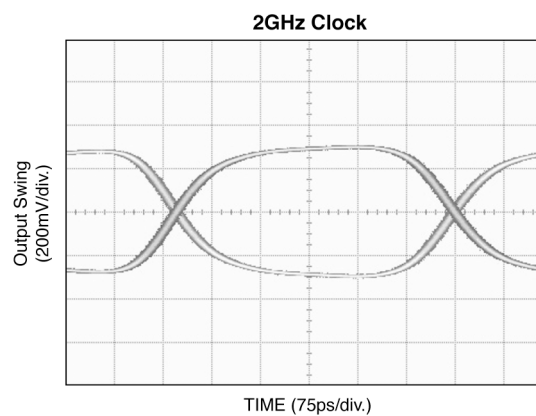
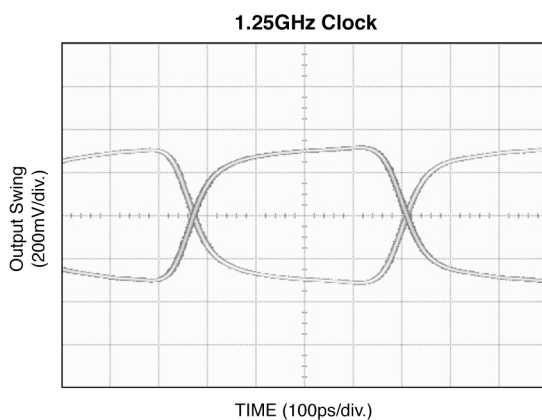
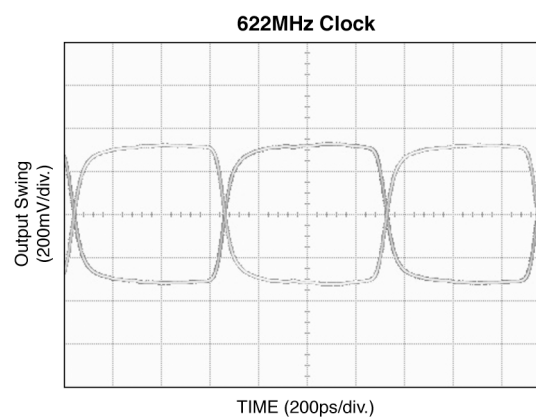
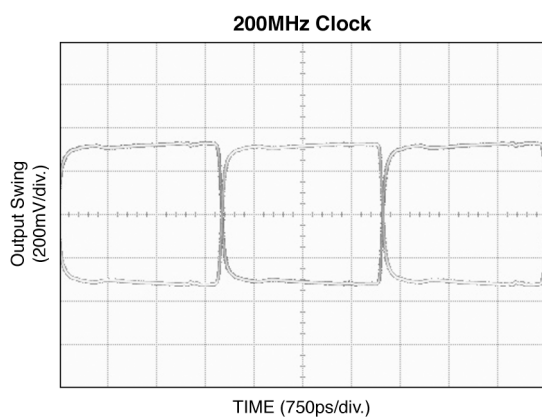
Typical Operating Characteristics

$V_{CC} = 2.5$, $GND = 0V$, $V_{IN} \geq 400mV_{pk}$, $t_r/t_f \leq 300ps$, $R_L = 100\Omega$ across output pair or equivalent; $T_A = 25^\circ C$, unless otherwise stated.



Functional Characteristics

$V_{CC} = 2.5$, $GND = 0V$, $V_{IN} \geq 400mV_{pk}$, $t_r/t_f \leq 300ps$, $R_L = 100\Omega$ across output pair or equivalent; $T_A = 25^\circ C$, unless otherwise stated.



Singled-Ended and Differential Swings

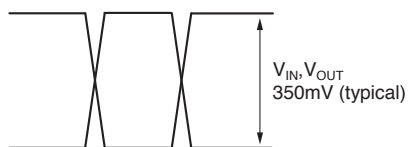


Figure 1a. Singled-Ended Voltage Swing

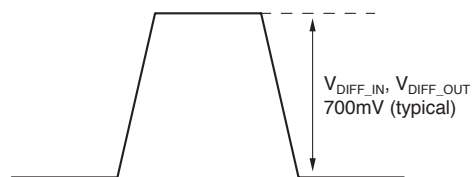


Figure 1b. Differential Voltage Swing

Input Stage

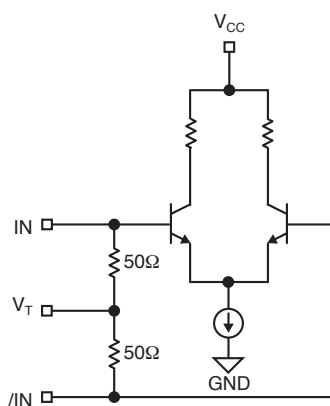


Figure 2. Simplified Differential Input Stage

Input Interface Applications

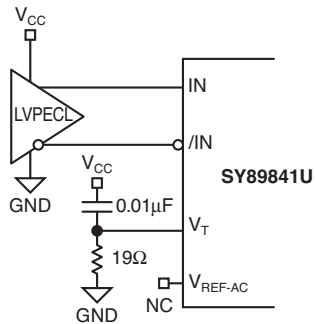


Figure 3a. LVPECL Interface (DC-Coupled)

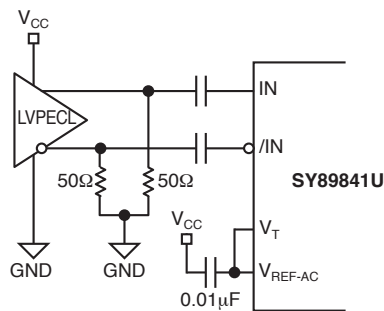
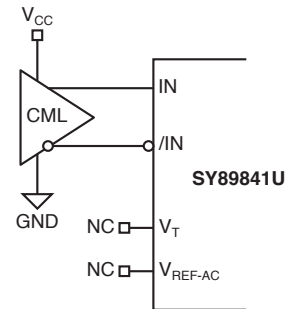


Figure 3b. LVPECL Interface (AC-Coupled)



Option: may connect V_T to V_{CC}
Figure 3c. CML Interface (DC-Coupled)

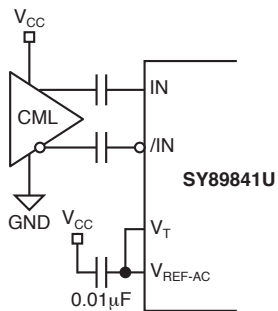


Figure 3d. CML Interface (AC-Coupled)

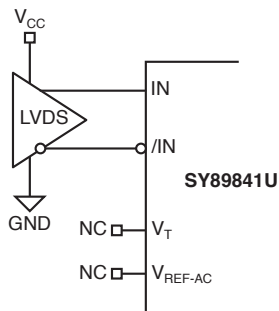


Figure 3e. LVDS Interface (DC-Coupled)

LVDS Output Interface Applications

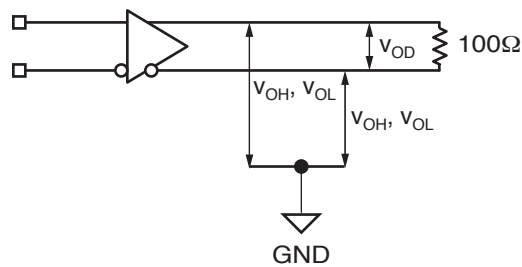


Figure 4a. LVDS Differential Measurement

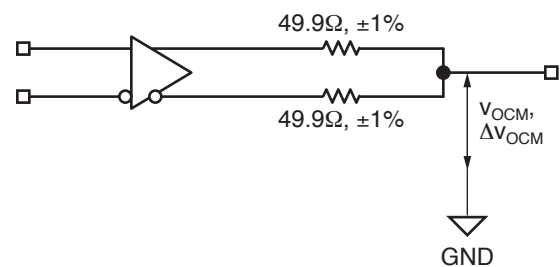
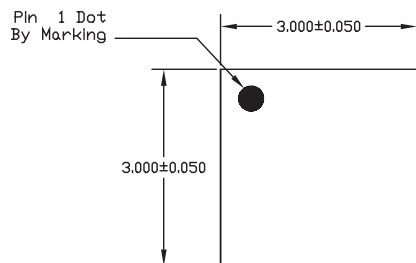


Figure 4b. LVDS Common Mode Measurement

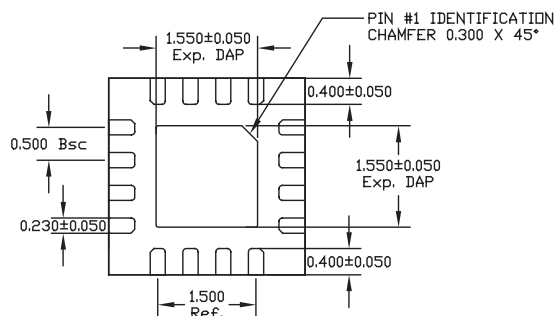
Related Product and Support Documentation

Part Number	Function	Data Sheet Link
SY89840U	Precision LVPECL Runt Pulse Eliminator 2 :1 Multiplexer	www.micrel.com/product-info/products/sy89840u.shtml .
SY89842U	Precision CML Runt Pulse Eliminator 2 :1 Multiplexer	www.micrel.com/product-info/products/sy89842u.shtml .
	MLF™ Application Note	www.amkor.com/products/notes_papers/MLFAppNote.pdf
HBW Solutions	New Products and Applications	www.micrel.com/product-info/products/solutions.shtml

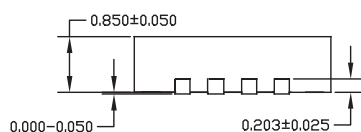
16 Lead *MicroLeadFrame*[™] (MLF-16)



TOP VIEW



BOTTOM VIEW



SIDE VIEW

NOTE:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. MAX. PACKAGE WARPAGE IS 0.05 mm.
3. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.
4. PIN #1 ID ON TOP WILL BE LASER/INK MARKED.

Packages Notes:

1. Package meets Level 2 Moisture Sensitivity Classification.
2. All parts are dry-packed before shipment.
3. Exposed pad must be soldered to a ground for proper thermal management.

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